Characterization of ion beam irradiated 304 stainless steel utilizing nanoindentation and Laue microdiffraction

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1. Introduction

Radiation damage in materials is a significant concern in advanced and conventional nuclear reactors, spallation sources, isotope production facilities and fusion technology applications. Embrittlement and environment interaction are key issues during lifetime extension or performance predictions for reactors [1–4]. Of particular interest is the effect of irradiation in stainless steels such as 304 and 316L due to their widespread use as structural materials in light water reactors [5]. However, when subjected to irradiation, austenitic steels harden due to the formation of defect clusters that act as obstacles to dislocation motion under an applied stress [6]. Depending on the material, irradiation temperature, and stacking fault energy of the system, these defect clusters can manifest themselves as stacking fault tetrahedra (SFT) and dislocation loops [7,8]. Furthermore, irradiation induced hardening results in a decrease in ductility, which has been well characterized in metals [9]. Therefore it is important to thoroughly characterize and understand both the defects that are introduced through irradiation and the corresponding change in mechanical properties.

Since reactor components become radioactive in service, especially stainless steels due to the high nickel content, ion beam irradiations are considered as a surrogate for reactor irradiations [10]. In addition ion beam damage has a significant higher damage rate than neutron irradiation and therefore high doses can be achieved in a matter of days rather than years. However, medium energy (2 MeV) light ions (H) have a limited penetration depth. Higher ion beam energies are possible but reduce the displacement per atom (dpa) rate while resulting in greater sample activation. One of the benefits of using a low energy proton beam is that it can be used to investigate radiation damage without highly activating the specimen. However one of the limitations to using a lower energy source is the limited penetration depth, therefore necessitating the use of nanoscale post irradiation characterization methods such as nanoindentation [11,12] and synchrotron radiation based X-ray Laue microdiffraction ($\mu$XRD) [13]. In this work, these methods are applied to investigate the change in mechanical properties as a result of ion beam irradiation and mapping of the microstructure induced by the ion beam irradiation.

In this study 304 stainless steel (304SS) was studied in two different dose conditions: 1 dpa, 10 dpa. Additionally, the 10 dpa sample was also annealed to determine whether the radiation damage can be annealed out at 500 °C. This paper reports the nanoindentation experiments of both configurations as well as
the corresponding μXRD of the irradiated region. The purpose
of this study is to characterize the hardening induced by ion
irradiation and correlate that with the defect density estimated
by μXRD.

2. Experimental

The irradiation experiment was conducted using 2 MeV protons
in a Tandetron accelerator at the Michigan Ion Beam Laboratory
(MIBL). Two specimens of 304SS were irradiated to 1 and 10 dpa,
respectively, at 360 °C with a dose rate of ~8 × 10^{-6} dpa/s based
on the SRIM calculation [14] (Full cascade option used with a dis-
placement energy of 40 eV for Fe, Cr and Ni). The equivalent doses
would be 0.5 and 5 dpa, respectively, if the K–P option is used in
SRIM. The sample temperature was monitored using a two-
dimensional (2D) thermal imager and the variation was kept with-
in ± 10 °C during the course of irradiation. A detailed description of
the proton irradiation procedure was published elsewhere [15].
The annealed specimen was subjected to 500 °C for 1 h in a
vacuum furnace. Fig. 1 summarizes the dose profile calculated
using SRIM where the x axis represents the penetration depth of
the ion beam in cross section.

2.1. Sample preparation for nanoindentation

Both the 1 dpa and 10 dpa samples were polished in cross
section with respect to the irradiated surface. During polishing
each sample was mounted directly next to a thin piece of steel to
prevent deformation and rounding near the edge of the specimen.
The samples were planarized using SiC grinding paper with water
as a lubricant and were then polished with 0.3 μm, 0.1 μm alumina
polishing solutions, and 0.05 μm colloidal silica polishing solution.

2.2. Nanoindentation measurements

Nanoindentation measurements were performed at the Nuclear
Materials Laboratory at the University of California, Berkeley on
the Micro Materials NanoTest™. The nanoindenter was calibrated
against fused silica before each indentation run to allow for cross
comparison between samples and indenters [16]. Indents were
200 nm deep and a minimum of 4 μm apart from each other to
ensure no interaction of the plastic zone around the indents. An
array of 10 × 8 indents was set near the irradiated edge and an
array of 8 × 8 indents was set on the opposite side where no beam
had hit the surface. Comparing the irradiated with the unirradiated
edge of the sample ensures that there were no edge effects, and
observed differences can be attributed to ion beam irradiation.

The indent field in the irradiated region were tilted towards the
edge intentionally to increase the depth resolution and potentially
resolve the stopping peak, which is shown in Fig. 2 [17]. The
indents were all performed in depth-control mode with a loading
and unloading rate of 2 mN/s and a dwell time of 5 s. The hardness
was obtained by the Oliver–Pharr method [18]. In support of the
nanoindentation measurements, an indentation size effect study
was performed on the surface of a 10 dpa specimen in both the
control and irradiated region. Indents were measured at various
depths. A set of three indents was performed at each unique depth.
The size effect study was performed on a Hysitron Triboindenter
using a Berkovich tip.

Each indentation field was examined using scanning electron
microscopy to verify the location of each indent with respect to
the sample edge. The data reported (hardness vs. depth from the
irradiated surface) reflects the SEM measurements.

2.3. μXRD study

Synchrotron radiation based Laue microdiffraction experiments
were conducted at Beamline 12.3.2 of the Advanced Light Source
(ALS) at Lawrence Berkeley National Laboratory [19]. A polychro-
matic X-ray beam (5–24 keV) was focused to ~ 1 × 1 μm² by a pair
of Kirkpatrick–Baez (KB) mirrors. A schematic of the Laue diffra-
tion setup can be found in the study presented by Kunz et al.
[20]. The samples were mounted on a high resolution x–y scan
stage with its polished cross-section facing up, and then tilted
45° relative to the incident X-ray beam. For each sample, a fast
fluorescence scan was conducted to position the sample edge so
as to ensure that all Laue diffraction scans covered the region from
the sample edge to about 100–150 μm towards the sample matrix.
In this study the diffraction scanning step size was 2 μm and the
exposure time at each position was 1 s. Diffraction patterns were
recorded in reflection mode with a 2D Pilatus detector mounted
at 90° to the incoming X-ray, approximately 140 mm from the
probe spot. The detector has 1043 × 981 pixels and each pixel is
about 170 × 170 μm² in size. Calibrations for sample-to-detector

![Damage Rate](image)

Fig. 1. Calculated SRIM dose profile showing the damage rate.
distance, center channel position and tilt of detector were performed by indexing a Laue diffraction pattern from a low-strain sharp diffraction pattern within the sample far from the edge using an in-house developed analysis software package XMAS [21]. Reflection peak shapes were fitted with a 2D Gaussian function so that the peak position and width were determined with a precision of about 0.1 pixels, providing an angular resolution of ~0.01°.

3. Results

3.1. Nanoindentation results

Fig. 3 shows the hardness profile as a function of irradiation depth in cross section indentation as described above. Starting from the original sample surface the hardness change as a function of distance from the edge is shown. Both sides (irradiated and not irradiated) are displayed for comparison reasons in one graph. The 1 dpa sample hardness profile is closely related to the calculated dpa profile (Fig. 1) with higher hardness at the end of the stopping region and less hardness at the near surface areas as it is displayed in Fig. 3. It was found that the hardness of the bulk was approximately (3.23 ± .36) GPa whereas in the irradiated region of the 10 dpa sample the hardness saturated at approximately (5.58 ± .22) GPa as shown in Fig. 4. Maximum hardness in the 10 dpa sample was achieved at 19.7 μm from the irradiated surface with a corresponding hardness of 6.05 GPa, whereas in the 1 dpa irradiated region the maximum hardness was reached at 20.8 μm from the irradiated surface (at the stopping peak) with a corresponding hardness of 6.13 GPa.

However, as can be seen in Fig. 4, the irradiated region in the 10 dpa sample exhibited a marked increase in hardness. Hardness in the irradiated region doubled with respect to the control region (from 3.2 to 5.5 GPa). Interestingly, no dose related profile (increase of hardness with indentation depth) was observed, suggesting that the maximum possible hardness increase was reached at 10 dpa in the flat part of the region and no additional hardening due to higher damage in the stopping peak was observed. Essentially it appeared that the amount of possible hardening is saturated at this dose. Fig. 2 shows an SEM micrograph of the corresponding indent field for the 10 dpa specimen.

The transition region can be found at a depth of ~21 μm depth which is slightly deeper than the calculated depth by SRIM. One possible reason for this discrepancy can be found in the fact that the volume tested by the indenter is in fact larger than the position of the indent. A 200 nm deep indent is ~1 μm wide and samples are ~2–2.5 μm wide area in × and × making spacing between indents of at least 4 μm necessary.

An indentation size effect study was also performed on both the irradiated region of the 10 dpa sample as well as an unirradiated specimen, as can be seen in Fig. 5. This study was only performed at the 10 dpa sample due to the fact that the 1 dpa sample showed such a strong hardness gradient in cross section that de-convoluting the size effect from the dose profile and therefore hardening...
The profile is challenging. The size effect is quantified using the Nix and Gao plot in the insert in Fig. 5 and discussed further in the discussion section. We also want to emphasize that the size effect and actual cross section hardness testing was performed on two different systems (Hysitron and Micromaterials) as well as with different indenters. The area functions produced by the two systems agree rather well.

In addition to the irradiated 10 dpa sample, an annealed 10 dpa sample was also evaluated. Fig. 6 summarizes the nanoindentation results for the annealed sample. Compared to Fig. 4, the irradiated region showed a small decrease in the measured hardness; however, as seen in Fig. 6, the annealing did not completely remove much of the damage that was induced by the ion irradiation.

3.2. Laue diffraction results

By indexing the μXRD patterns assuming face-centered cubic iron phase, the crystal orientation at all scanning positions is obtained, and the out-of-plane orientation map of the 10 dpa irradiated sample near the irradiation edge is demonstrated in Fig. 7a. Colors indicate lattice orientations at each scan spot as given by the color scale (inset). White spots in the figure suggest that there are no or only very low-intensity diffraction patterns recorded, either...
because the beam is out of the sample (the upper part of the figure) or as a result of defects/impurities (within the sample). Twins are clearly visible in the orientation map and the twin plane is the (111) plane. For over 80% of the scanned area the (100) or (110) plane normals are parallel to the out of plane normal. The grain size is much larger than 40 μm, so that it is probable that the array of nanoindentation (32 μm × 28 μm in area) was performed within a single crystal grain.

Diffraction peak broadening is correlated to the defect density in a specimen [22,23]. The peak width distribution in the scanned 10 dpa irradiated sample is plotted in Fig. 7b. The peak width here is defined as the average FWHM, in the unit of degrees, of all recorded reflections in each Laue diffraction pattern. A sharp boundary is observed in this map, indicating that the diffraction peaks taken from the region within approximately 20 μm from the sample surface are significantly broadened compared to those beyond the proton range. Typical Laue patterns from the matrix and surface of the specimen are demonstrated in Fig. 7c and d, respectively. Although these two patterns were taken on a crystal in which the orientation stays nearly unchanged, the shape of the peaks from both patterns is clearly different. The peaks in Fig. 7c are only slightly wider than the ones taken on defect-free thin Si films, while in Fig. 7d all the peaks are broadened. In order to reveal the mechanism that the peak broadening is rooted from, quantitative peak shape analysis is performed on one of the typical broadened peaks, the peak 115 in Fig. 7d. First of all, the peak is re-plotted in the Bragg–azimuthal angle (2θ–χ) space, as shown in Fig. 7e. Then the intensity of the diffraction peak is scrutinized in both 2θ and χ directions along the dashed lines drawn in Fig. 7e, and fitted with Gaussian function, respectively (displayed in Fig. 7f). It is found that although appearing elongated anisotropically on the detector image in Fig. 7d, the diffraction peak shape becomes more isotropic in the angular 2θ–χ space. The FWHM in the 2θ and χ directions is 0.63° and 0.59°, respectively. The isotropic broadening indicates statistically stored dislocations (SSDs), with equal number of positive and negative Burgers vectors rather than an ordered array of unpaired geometrically necessary dislocations (GNDs), which leads to linearly streaked reflections [24–26].

The peak width distribution maps of the unirradiated, 1 dpa, and annealed 10 dpa samples are shown in the same color scale in Fig. 8a–c, respectively. Not surprisingly, the unirradiated specimen gives sharp and uniform diffraction peaks over the entire scanned area. The matrix of both the 1 dpa and the annealed 10 dpa samples diffract similarly sharp as the unirradiated one, while the reflections from the surface of the irradiated ones are broadened. Although the affected depth shows little dependence of the irradiation dose and/or thermal treatment, the damage is more severe in the 10 dpa sample than in the 1 dpa one, even after annealing for 1 h at 500 °C. However, comparing Fig. 8c with Fig. 7b, it is concluded that the damage is slightly recovered by the annealing, evidenced by less broadened peaks (less red–orange but more green spots are found in Figs. 8c than in 7b).

4. Discussion

As shown in the results it was found that the hardness increases due to 1 dpa irradiation following the damage profile calculated by SRIM, and the hardness at the 10 dpa sample plateaus over the entire radiation damaged region despite the fact that the SRIM profile predicts an increasing dose of one order of magnitude from the flat part of the region to the peak. This strongly suggests that past a dose of 10 dpa, no further hardening can be detected which suggests that the material is saturated in radiation induced defects. Similar effects are seen on reactor irradiated samples where no further change is observed on 304SS irradiated beyond 10 dpa at 330–375 °C [27]. Spallation source irradiated material or lower temperature 275 °C reactor irradiation shows this saturation at doses as low as 3–4 dpa [10,28]. In this experiment it can be seen that the 1 dpa sample shows a similar hardness at the end of range at approximately 20 μm where the dose is ~10 dpa as well. Therefore we propose that saturation occurs by 10 dpa in our study. While in our study it is still difficult to state the exact dose at which

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![Fig. 8. FWHM map of the sample unirradiated (a), 1 dpa irradiated (b), and annealed 10 dpa irradiated (c) samples. The scale bar provided applies to all three images.](image)
hardening occurs due to the lack of intermediate dose samples in between where also a plateau would be expected at a specific depth, it appears that our data agrees well with ~330 °C irradiated materials from reactors. However, it can also be stated that the effect of saturation is not unique to this irradiation but has been observed in the other studies mentioned above and agrees well with the literature.

In order to correlate the data shown here with macroscopic mechanical tests it is necessary to account for the size effect observed with nanoindentation as first reported by Schulz et al. [29] and widely studied on a number of materials [30–33]. In our study it was found that the irradiated material shows a significantly smaller size effect than the unirradiated material. Utilizing the Nix and Gao equation one can calculate the parameters $H_0$ and $h$ which accounts for the size effect. The Nix and Gao model provides a description of the depth dependence of hardness. $H_0$ is the hardness that arises from SSDs alone and characterizes the hardness of infinite depth, in the absence of any GNDs, and $h$ is a length that characterizes the depth dependence of the hardness. It was found that for the irradiated material $H_0$ and $h$ are 4.75 and 7.41, respectively. The unirradiated material $H_0$ and $h$ are 1.91 and 319.2, respectively. Comparison with literature values (smaller $h$ and higher $H_0$ numbers) reveals that the irradiated material shows a trend similar to cold worked materials where the deformed material shows a smaller size effect [34]. This is based on the fact that both cold working and irradiation cause an increase in dislocations and therefore a decreased size effect as discussed in [35]. Taking into account the fact that typical Vickers hardness is measured in kg/mm$^2$ and the slightly different geometry one comes to the conclusion that between Vickers hardness and nano hardness the Eq. 1 applies:

$$H_V = 0.0945 \cdot H_{Berk}$$

where the indenter geometry is considered [35]. In [36] the factor 0.0937 is used in the same equation based on empirical values. We utilize the geometrical relationship based on A.C. Fisher-Cripps, and calculate a micro hardness of 448 $H_V$ on the irradiated material and 180 $H_V$ on the unirradiated material. Jiao et al. [37] found the unirradiated hardness from micro hardness measurements to be $(174 \pm 6) H_V$ and after 10 dpa irradiation it is $(385 \pm 19) H_V$ also on 304SS which is in reasonable agreement with the nanoindentation work here. In the literature micro hardness testing was carried out on 304SS before and after cold work and irradiation and it was found that the as received material had an $H_V$ of 200 and 380 after 1.67 dpa [38]. Additionally similar values were reported for as received material: 188 $H_V$ and 270 $H_V$ after $1.43 \times 10^{20}$ neutrons/cm$^2$ or 220 $H_V$ as received and 326 $H_V$ to 2.5 dpa [39]. Therefore it can be stated that our values measured here are in reasonable agreement with the literature.

The relationship between hardness and yield strength has been studied extensively and a number of different relationship parameters have been proposed. Bruemmer et al. [40] reported the linear relationship: 

$$\sigma_y = 2.5(H_V - 68),$$

while Toloczko et al. [41] reported 

$$\sigma_y = 2.7H_V - 125.$$  

Rodriguez et al. [31] proposed the equation:

$$H_V = 4.15 \sigma_y$$

Obviously the actual calculated yield stress numbers depend on which relationship is utilized. It has to be pointed out that all of these relationships are purely empirical, and based on various materials. These relationships described above lead to a yield stress of 330 MPa using Eq. (2) (Bruemmer), 415 MPa using Eq. (3) (Toloczko) or 530 MPa using Eq. (4) (Rodriguez) in the as received state. For the 10 dpa irradiated case this translates to a yield stress of 1022 MPa applying Eq. (2) (Bruemmer), 1162 MPa using Eq. (3) (Toloczko) or 1216 MPa using Eq. (4) (Rodriguez).

Other more elaborate and theoretical correlations do exist as proposed by Cahoon et al. [42] but require strain exponent considerations which are not part of this indentation study.

Busby et al. [43] did the most elaborate empirical study on the correlation between micro hardness and yield stress with a significant number of irradiated materials and found that the change in hardness due to irradiation is related to the change in yield stress by $\Delta \sigma_y = 3.03 \Delta H_V$. Leading to 812 MPa difference in yield strengths (irradiated–unirradiated) based on our hardness measurements, which is slightly higher than what is calculated with the other relationships mentioned above.

Unfortunately there is not sufficient reference material available for tensile testing that would lend support for one method over another but future research will be geared towards these comparisons. It is important to note that while no further hardness change can be observed beyond 10 dpa, other phenomena like local element segregation can still exist and contribute to further materials degradation.

The second part of this work features a microstructure evaluation of the irradiated material using a microdiffraction approach. In order to evaluate the dislocation density evolution as a function of irradiation dose and thermal history, the diffraction peak width is investigated in more detail from the very edge of the sample. For statistics three diffraction patterns at each depth are selected, and from each pattern a peak within the Bragg angle range of 35°–38° is fitted with a 2D Gaussian function after background subtraction. The Bragg angle of the peaks is in a range but not a specific value because of two reasons. First, the areas scanned in various samples cover more than one crystal grain. Due to the characteristics of Laue diffraction technique, the Bragg angle relies on not only the d-spacing of the crystal plane, but also the orientation of the crystal grain. Thus it is not easy (or even not possible) to find a diffraction peak that appears at the same Bragg angle in all these scans. The second reason is even more universal and important. Since the synchrotron based Laue μXRD method employed in this study provides an extremely high crystal orientation resolution, even in the same crystal grain, the local crystal orientation variation due to the residual stress is detectable, indicated by the peak position shift [23]. Therefore, the best option is to compare the diffraction peaks that appear in an angular range as narrow as possible. The distribution of diffraction peak FWHM along the depth direction in as-irradiated 10 dpa, irradiated 10 dpa annealed, and as-irradiated 1 dpa is displayed in Fig. 9. Comparing to the unannealed 10 dpa irradiated specimen, in which the FWHM of
the diffraction peak changes from 0.5° to 1° within 4 μm, annealing reduces the width of the diffraction peak in the damaged layer, while the shape and width of the transition region is almost unchanged. The 1 dpa irradiated sample, in contrast, does not show as dramatic peak broadening compared to the 10 dpa sample. The diffraction peak width, from a nonideal crystal with high density of paired SSDs, in the plane perpendicular to the diffraction vector is linked to the total density of dislocations (n) by [22,44]:

\[ \text{FWHM} \propto \sqrt{n} \]

Therefore we can estimate the change in dislocation density by the measuring the change in FWHM. Based on the observation that the Laue diffraction peaks are broadened almost isotropically, we further assume the majority of the defects are dislocation loops, similar to the previous work shown by Jiao et al. [37] Using this correlation, the dislocation density in the damaged layer in the 10 dpa irradiated region is calculated, from Fig. 9 and Eq. (5), to be 50–80 times of what it is in the unirradiated area. It is found here that annealing reduces the FWHM and therefore the assumed dislocation density by a factor of 2–4, after 500 °C for 1 h but still is about 30 times higher than in the matrix. In the 1 dpa sample, the dislocation density introduced by irradiation is more than one order of magnitude less than in the 10 dpa sample.

As stated above the dislocation density is related to FWHM by Eq. (5). Yield strength however, is also related to the dislocation density by:

\[ \sigma_y = \sigma_{y0} + k \sqrt{n} \]

Therefore plotting change in hardness which is a function of yield strength vs. change in FWHM which is a function of dislocation density should lead to a linear relationship as shown in Fig. 10. This correlation links the observed changes in the mechanical response with the increase in defect density that is attributed to irradiation.

5. Conclusion

In order to understand the microstructural evolution due to irradiation damage and the resulting mechanical response, it is necessary to fully characterize materials that are utilized in irradiation environments. Since ion beam irradiation does not allow the use of large scale mechanical tests small scale mechanical testing like nanoindentation can be utilized. In this study we correlated mechanical property response that is associated with various irradiation conditions with the defects induced during irradiation. Comparing the nanoindentation data with FWHM from Laue microdiffraction we suggest that a linear correlation between these two parameters may exist considering that FWHM and nanoindentation are based on the dislocation density. Further investigation is needed on this matter since only limited datapoints are available at this point in time. It was found that the 304SS shows no FWHM gradient associated with the ion beam irradiation profile and therefore no strong gradient in dislocation density. The 1 dpa sample shows a gradient through the implantation depth leading to the conclusion that the defect saturation is reached at 10 dpa.

References